

**Search Notes**

Application/Control No.

10/691,153

Examiner

Nhan T. Tran

Applicant(s)/Patent under  
Reexamination

HIROSE, HISATAKA

Art Unit

2622

**SEARCHED**

Class	Subclass	Date	Examiner
348	222.1	1/24/2007	NT
348	220.1	5/22/2007	NT

**INTERFERENCE SEARCHED**

Class	Subclass	Date	Examiner
PGPUB text search - see search history printout		5/23/2007	NT

**SEARCH NOTES  
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
EAST search (USPAT, PGPUB, JPO, EPO, DERWENT, IBM_TDB)	5/22/2007	NT
348/272-283 (text search - see search history printout)	5/23/2007	NT
348/241-251 348/294-324, 440.1, 441 (text search - see search history printout)	5/23/2007	NT
382/298-300, 254, 258 (text search - see search history printout)	5/23/2007	NT
358/1.2, 500, 513, 514, 528, 530, 533 (text search - see search history printout)	5/23/2007	NT
text search all databases listed above	5/23/2007	NT
Inventorship search - see search history printout	5/23/2007	NT